



# Analytical Methods for Materials

## Lesson 20

### Components in an X-ray Diffractometer

#### Suggested Reading

Chapter 6 in Cullity & Stock

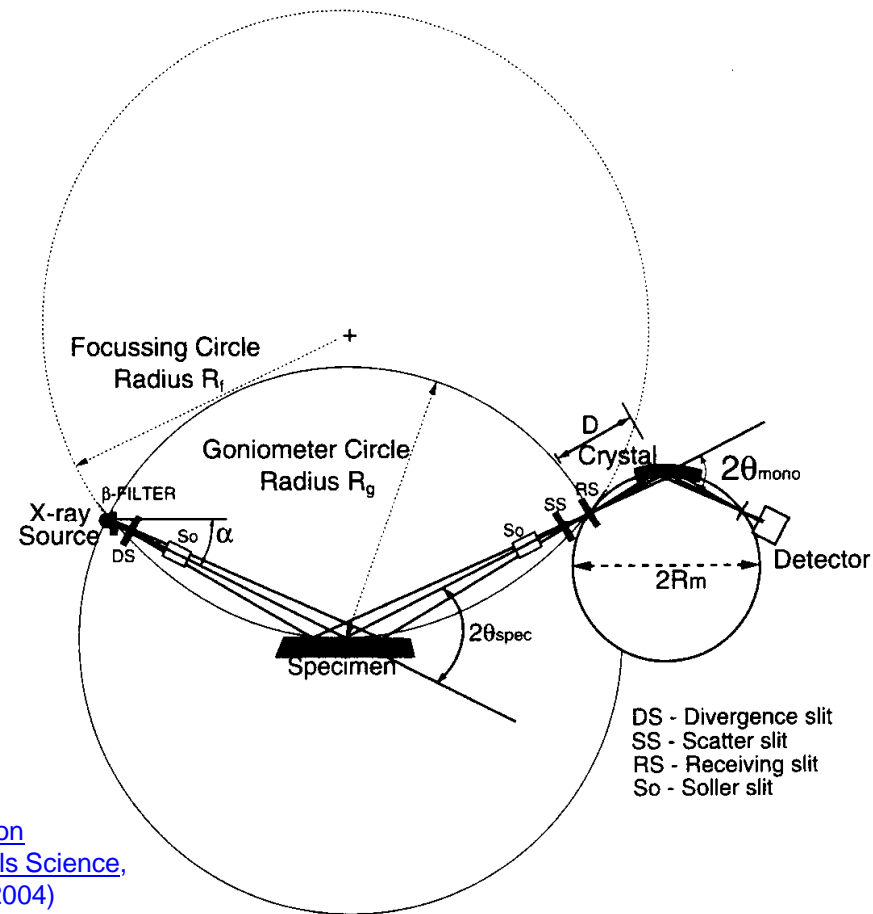
Chapter 2 in Brandon & Kaplan

# Geometry of the X-ray Diffractometer

- Generically, diffractometers consist of:

- X-ray source
- X-ray detector
- Specimen to be examined
- Other things

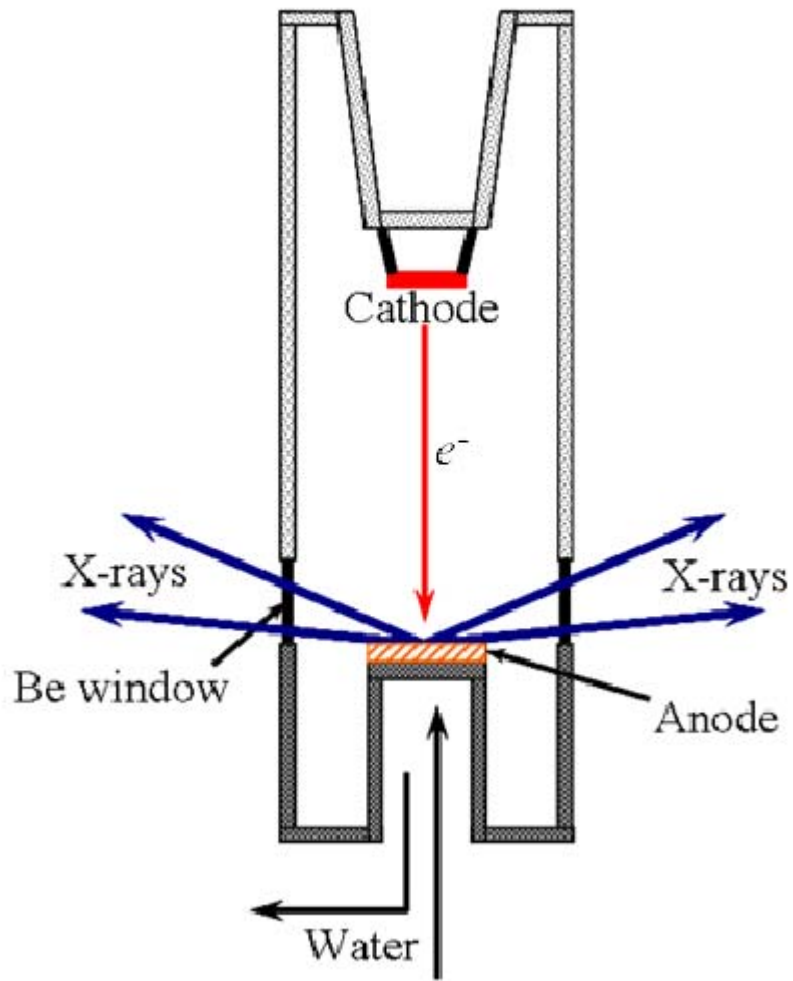
- Monochromators
- Filters
- Slits
- Etc...



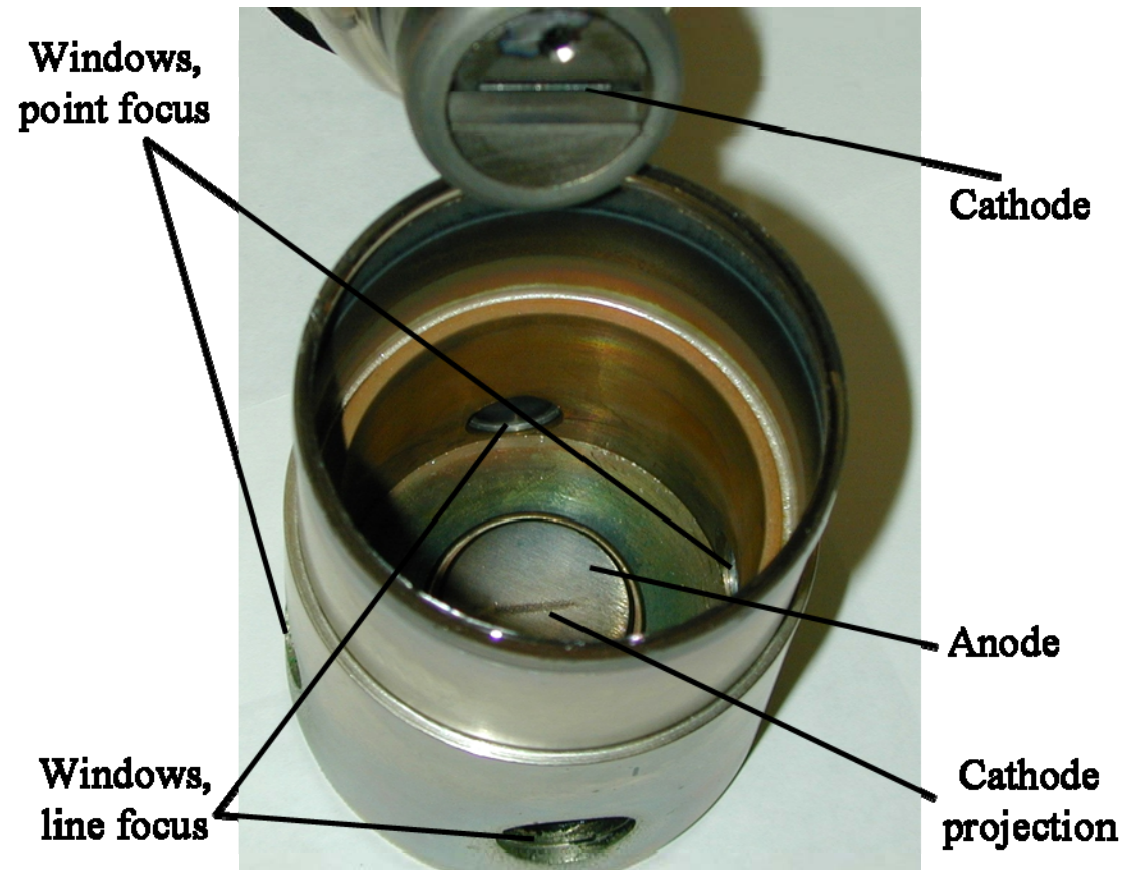
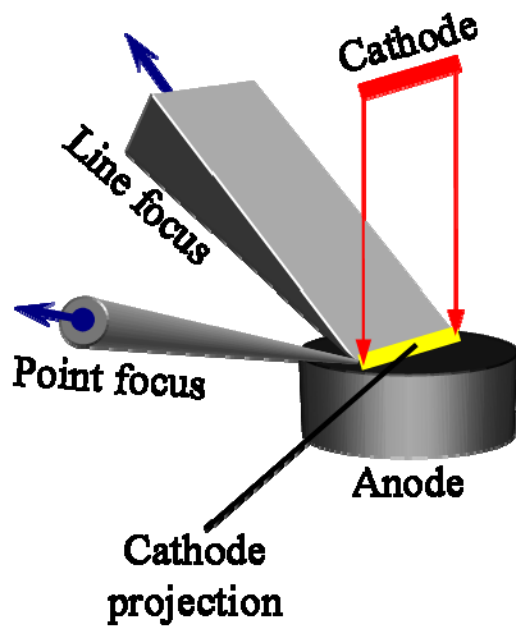
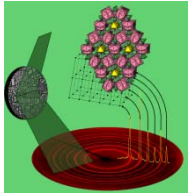
D.J. Dyson, [X-ray and Electron Diffraction Studies in Materials Science](#), Maney Publishing, London (2004)

**Fig. 5.5** The geometry of the diffractometer arrangement: DS is the divergence slit, SS is the scatter slit, RS is the receiving slit, So is the soller slit.

*X-ray tube*



Adapted from Vitalij K. Pecharsky and Peter Y. Zavalij, [Fundamentals of Powder Diffraction and Structural Characterization of Materials](#), Kluwer Academic Publishers, 1999.



*X-ray tubes will have line focus and point focus windows*

# Soller Slits

## Divergence Slits

- Closely spaced parallel metal planes parallel to the plane of the diffractometer circle that collimate the incident beam. They are usually constructed of a high atomic number element to maximize absorption.

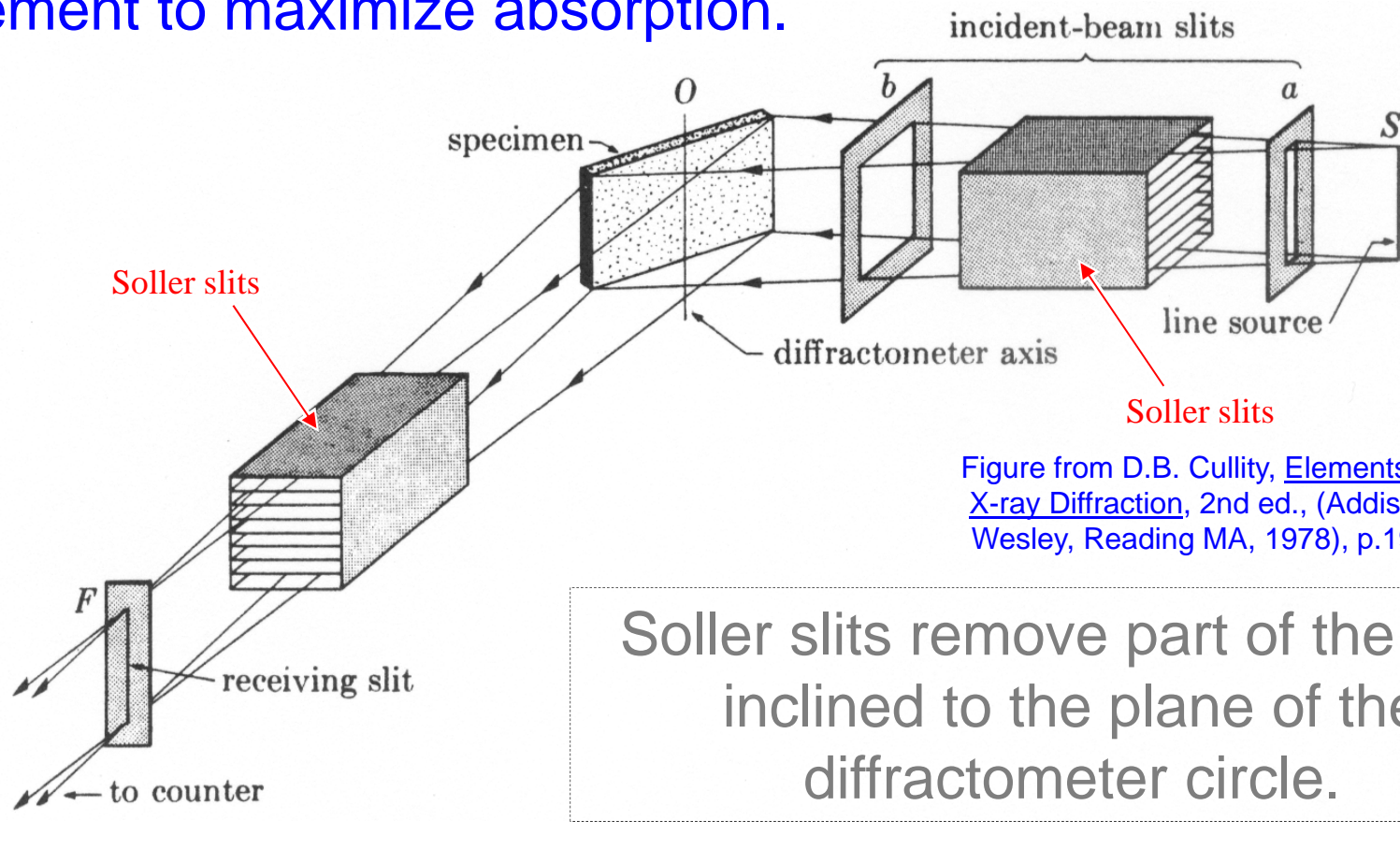
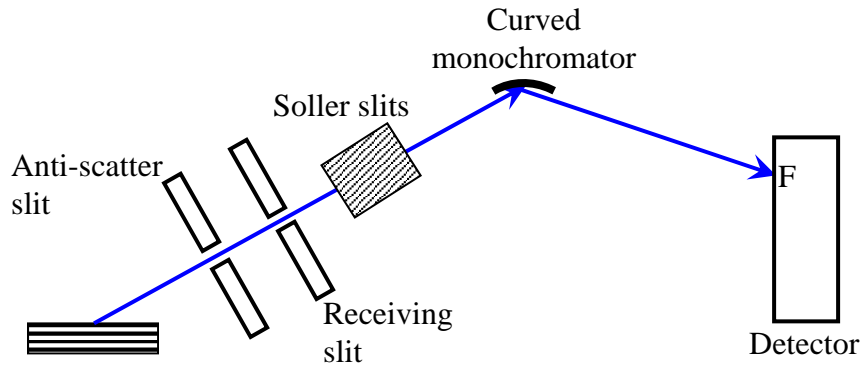


Figure from D.B. Cullity, [Elements of X-ray Diffraction](#), 2nd ed., (Addison Wesley, Reading MA, 1978), p.199

Soller slits remove part of the rays inclined to the plane of the diffractometer circle.

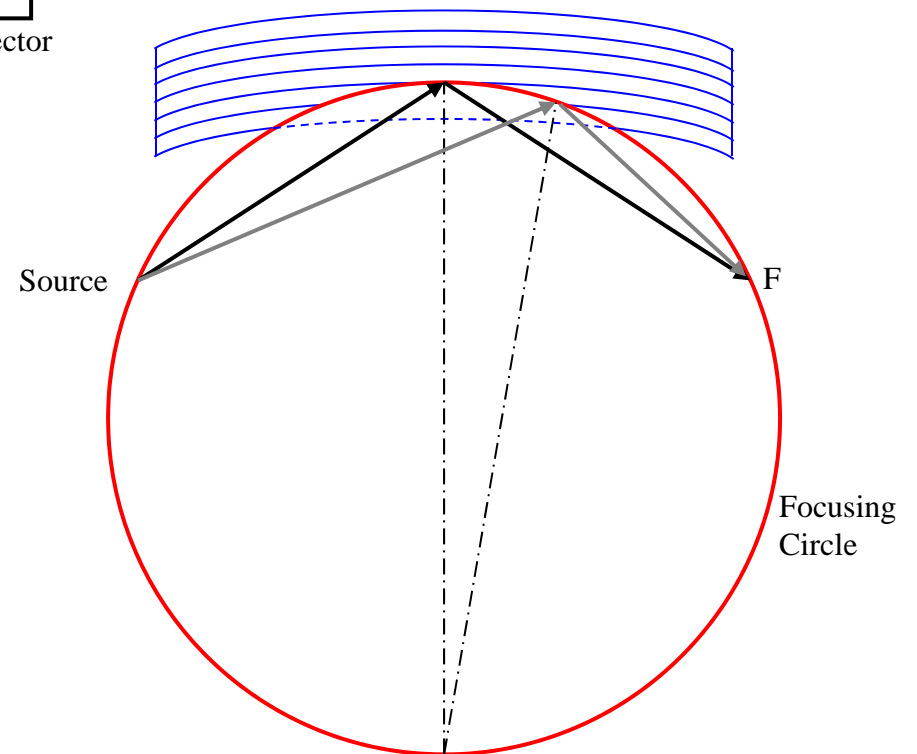


# Monochromator



A device in neutron and X-ray optics to select a defined wavelength of the radiation for further purpose

They re-focus the diffracted beam just as a parabolic mirror is used to focus light.



**Eliminates Fluorescence!**



# X-ray Detectors

**Table i7.1** Properties of different detector types.

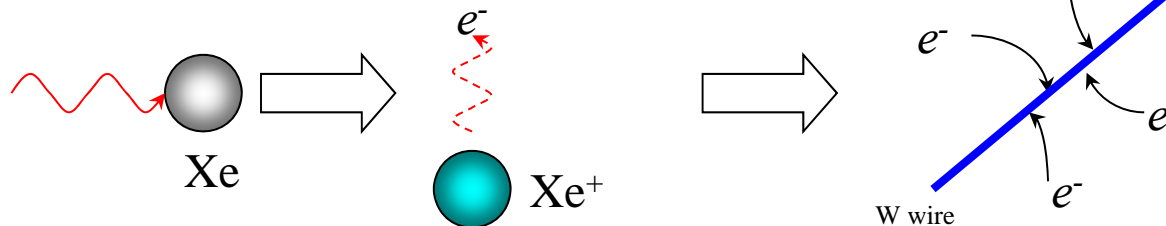
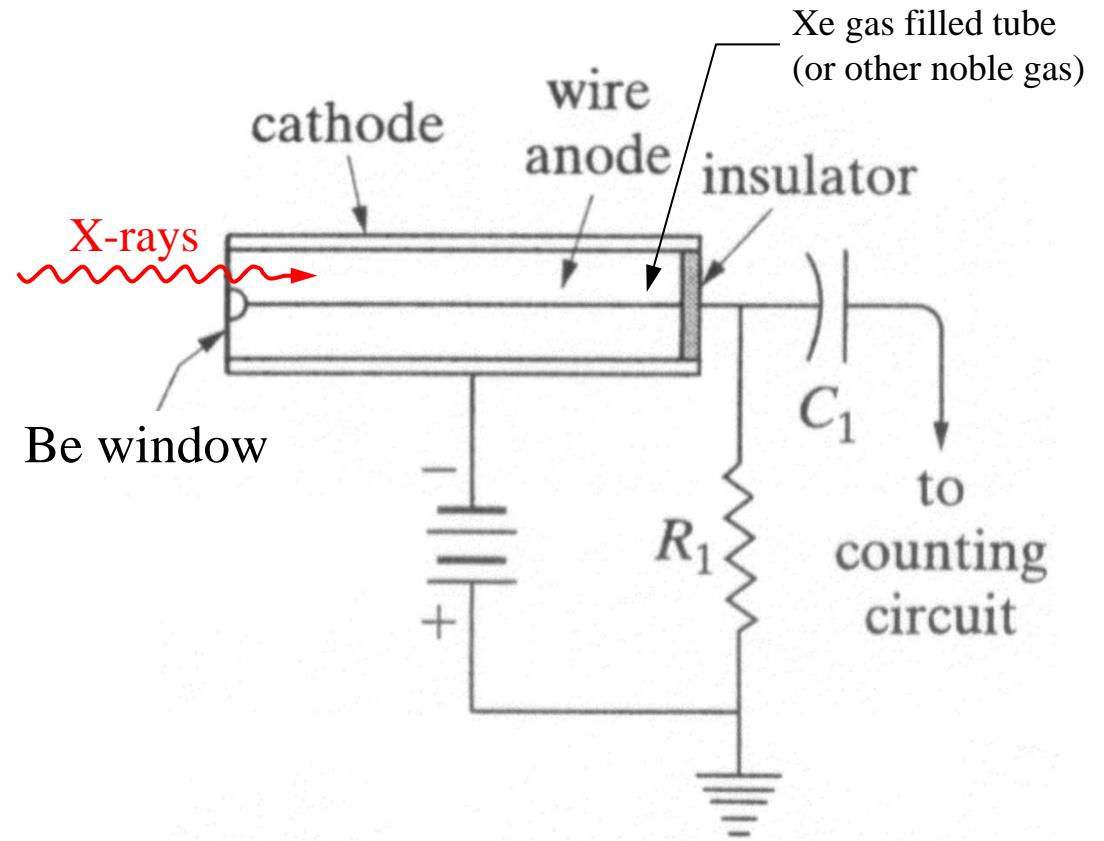
	<b>Proportional counter</b>	<b>Scintillation counter</b>	<b>Solid-state detector</b>
Working principle	Electron–ion pair cascade	Conversion to light and electrons and electron multiplication	Generation and separation of electron–hole pairs
Transducing medium	Xe	NaI:Tl	Si, Ge
Noise rate (cps)	1	0.1–10	<0.1
Maximum count rate (cps)	$10^5$ – $10^6$	$10^5$ – $10^6$	$10^4$
Resolution $\Delta E/E$ (%)	18–20	40–50	depends on type
Costs	Low	Medium	High

From M. Birkholz, [Thin Film Analysis by X-ray Scattering](#), Wiley-VCH, Weinheim, 2006, p. 254

# Proportional Detector

- Most common type of detector in powder diffraction.

Adapted from B.D. Cullity and S.R. Stock, *Elements of X-ray Diffraction, 3<sup>rd</sup> Edition*, Prentice-Hall, Upper Saddle River, NJ (2001) page 203.





# The way proportional detectors work

- X-rays enter the tube and are absorbed by gas atoms.
  - Results in the emission of a photoelectron (i.e., an electron produced by ionization of an atom by a photon).
- Released electrons are attracted to the W wire, resulting in a charge pulse.
  - The charge collected on the W wire is “proportional” to the energy of the incident x-ray photon. This allows us to distinguish between photons with different  $E$  and  $\lambda$ .

# Scintillation Detector

- Uses a NaI single crystal doped with Thallium ions ( $Tl^+$ ) attached to a photocathode and photomultiplier tube.

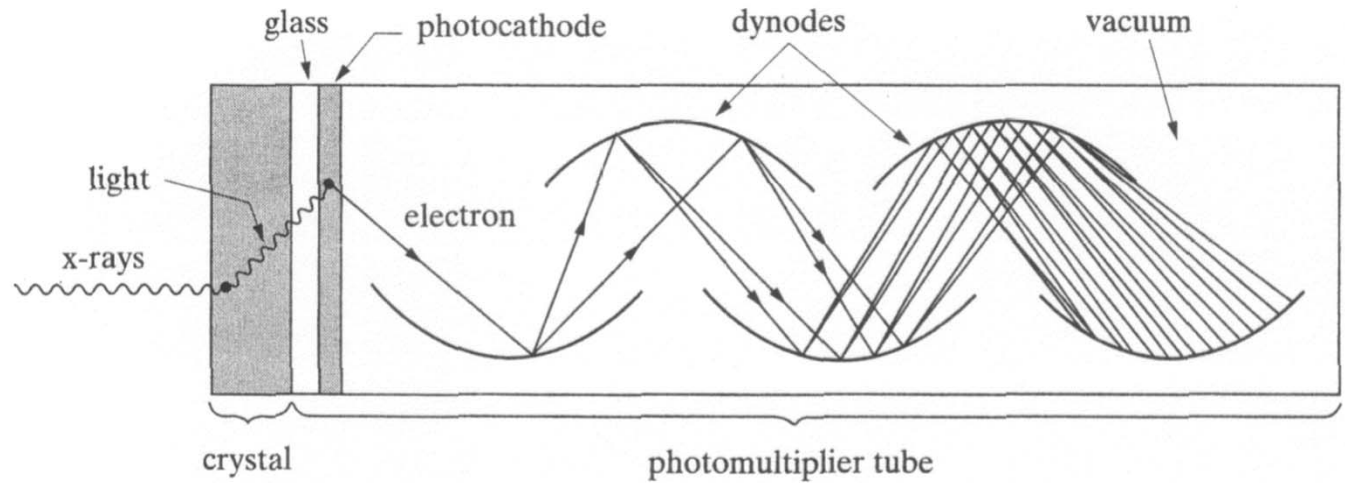
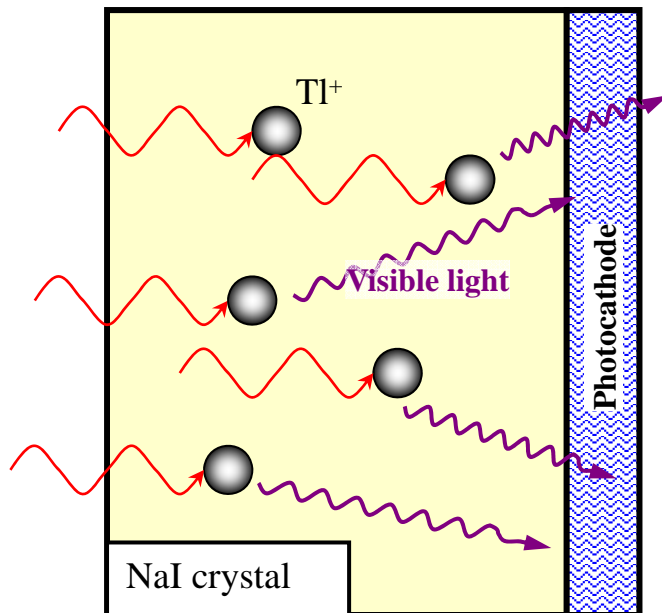


Figure 6-21 Scintillation detector (schematic). Electrical connections not shown.



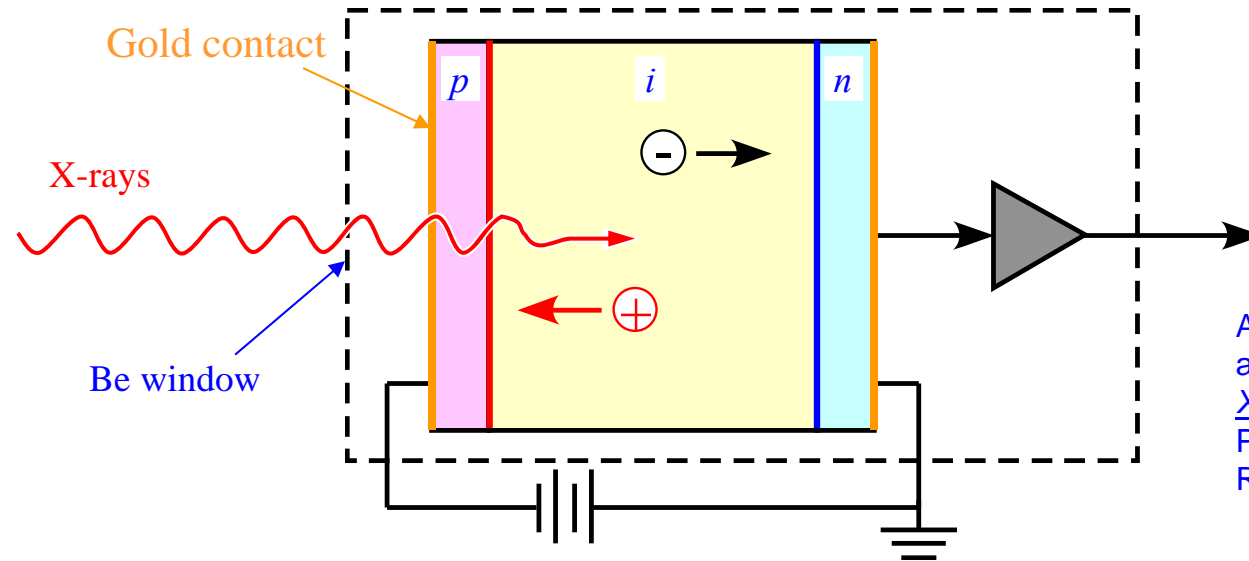
Adapted from B.D. Cullity and S.R. Stock, *Elements of X-ray Diffraction, 3<sup>rd</sup> Edition*, Prentice-Hall, Upper Saddle River, NJ (2001) page 207.

# The way scintillation detectors work

1. Incident x-rays cause the crystal to fluoresce in the violet part of the EM spectrum.
2. A flash of light (*scintillation*) occurs for every X-ray photon absorbed.
3. Light is measured with a photomultiplier attached to the photocathode.
4. Amount of light emitted is proportional to the X-ray intensity.
5. The magnitude of the light pulses is proportional to the energy of the X-rays.

Has lower resolution than proportional or solid state detectors.

# Solid State Detector



Adapted from B.D. Cullity and S.R. Stock, *Elements of X-ray Diffraction, 3<sup>rd</sup> Edition*, Prentice-Hall, Upper Saddle River, NJ (2001) page 210.

Schematic of a Si(Li) detector and a field effect transistor (FET) preamplifier. Both are in a cooled evacuated space. X-rays enter through a beryllium window. The detector is operated at around 1000 V.

- Based on the PIN diode
- Allows separation of  $\text{CuK}_\alpha$  and  $\text{CuK}_\beta$
- Eliminates the need for a  $\beta$ -filter or a monochromator to select  $\text{K}_\alpha$  wavelengths.
- If it's advantageous one can record the XRD pattern using  $\text{K}_\beta$  radiation as opposed to  $\text{K}_\alpha$ .
- Lower background signal which leads to improved signal to noise ratios.

# The way solid state detectors work

- X-rays excite electrons from the valence band into the conduction band creating an electron hole pair.
- Application of a reverse bias potential causes the electrons and holes to separate, which allows a charge pulse of electrons to be measured.
- The number of electrons or holes is directly proportional to the energy of the x-ray photon.
- Solid state detectors offer the highest levels of efficiency and the highest resolution.